Search Notes				

Application/Control	No. Applicant(s)/Patent unde Reexamination	r
10/651,648	TEIJIDO ET AL.	
Examiner	Art Unit	
Audrey Y. Chang	2872	

SEARCHED			
Class	Subclass	Date	Examiner
359	577	6/29/2005	AC
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359	619		
359	634		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEA (INCLUDING	ARCH NOT SEARCH :	ES STRATEGY)
		DATE	EXMR
EAST		6/29/2005	AC